

**Search Notes**

Application/Control No.

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Examiner

YONG D. PAK

Applicant(s)/Patent under  
Reexamination

BOGOSIAN ET AL.

Art Unit

1652

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
stic: seq id no:2, see SCORE	10/13/2008	YP
EAST (all databases): see search history	10/13/2008	YP
PALM: search of all inventors	10/13/2008	YP